

## IF3601

## N-Channel Silicon Junction Field-Effect Transistor

- Low-Noise, High Gain Amplifier

**Absolute maximum ratings =  $T_A$  at 25°C**

Reverse Gate Source Voltage & Gate Drain Voltage	- 20 V
Continuous Forward Gate Current	10 mA
Continuous Device Power Dissipation	300 mW
Power Derating	2 mW/°C
Storage Temperature Range	- 65°C to 200°C

At 25°C free air temperature:

**Static Electrical Characteristics**

	IF3601		Process NJ3600L		
	Min	Max	Unit	Test Conditions	
Gate Source Breakdown Voltage	$V_{(BR)GSS}$	- 20	V	$I_G = - 1 \mu A$ , $V_{DS} = \emptyset V$	
Gate Reverse Current	$I_{GSS}$		nA	$V_{GS} = - 10V$ , $V_{DS} = \emptyset V$	
Gate Source Cutoff Voltage	$V_{GS(OFF)}$	- 0.35	- 2	V	$V_{DS} = 10V$ , $I_D = 0.5 nA$
Drain Saturation Current (Pulsed)	$I_{DSS}$	30	mA	$V_{DS} = 10V$ , $V_{GS} = \emptyset V$	

**Dynamic Electrical Characteristics**

Typ

Common Source Forward Transconductance	$g_{fs}$	750	mS	$V_{DS} = 10V$ , $V_{GS} = \emptyset V$	f = 1 kHz
Common Source Input Capacitance	$C_{iss}$	300	pF	$V_{DS} = \emptyset V$ , $V_{GS} = - 4V$	f = 1 MHz
Common Source Reverse Transfer Capacitance	$C_{rss}$	200	pF	$V_{DS} = \emptyset V$ , $V_{GS} = - 4V$	f = 1 MHz
Equivalent Short Circuit Input Noise Voltage	$\bar{e}_N$	0.3	nV/ $\sqrt{Hz}$	$V_{DG} = 3V$ , $I_D = 5 mA$	f = 100 Hz

**TO-39 Package**  
Dimensions in Inches (mm)

**Pin Configuration**  
1 Source, 2 Drain, 3 Gate & Case